



NTE5538 Silicon Controlled Rectifier (SCR) 800V_{DRM}, 50A

Description:

The NTE5538 general purpose SCR is suited for power supplies up to 400Hz on resistive or inductive loads.

Features:

- Glass Passivated Chip
- High Stability and Reliability
- High Surge Capability
- High On-State Current
- Easy Mounting on Heatsink
- Isolated Package: Insulating Voltage 2500V_{RMS}

Absolute Maximum Ratings:

Peak Forward Blocking Voltage ($T_J = +125^\circ\text{C}$), V_{DRM}	800V
Peak Reverse Blocking Voltage ($T_J = +125^\circ\text{C}$), V_{RRM}	800V
RMS On-State Current ($T_C = +70^\circ\text{C}$, Note 1), $I_T(\text{RMS})$	50A
Average On-State Current ($T_C = +70^\circ\text{C}$, Note 1), $I_T(\text{AV})$	32A
Non-Repetitive Surge Peak On-State Current (T_J initial = $+25^\circ\text{C}$, Note 2), I_{TSM}	
($t = 8.3\text{ms}$)	525A
($t = 10\text{ms}$)	500A
I^2t Value ($t = 10\text{ms}$), I^2t	1250A ² sec
Critical Rate of Rise of On-State Current (Note 3), di/dt	100A/ μs
Storage and Operating Junction Temperature Range, T_{stg}, T_J	-40° to $+125^\circ\text{C}$
Thermal Resistance	
Junction-to-Case for DC, R_{thJC}	1°C/W
Contact (Case-to-Heatsink), R_{thCH}	0.2°C/W

Note 1. Single phase circuit, 180° conducting angle.

Note 2. Half sine wave.

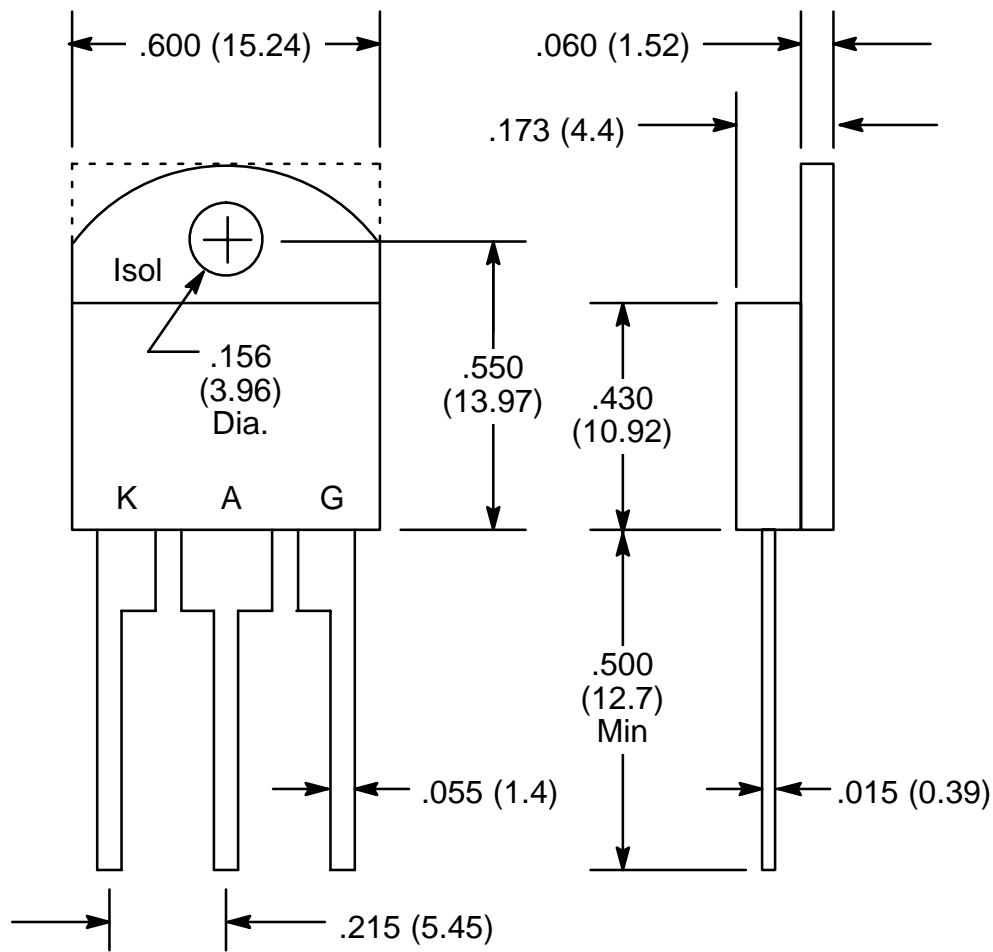
Note 3. $I_G = 800\text{mA}$, $di_G/dt = 1\text{A}/\mu\text{s}$.

Gate Characteristics: (Maximum Values)

Peak Gate Power ($t = 10\mu\text{s}$), P_{GM}	50W
Average Gate Power Dissipation, $P_G(\text{AV})$	1W
Peak Forward Gate Current ($t = 10\mu\text{s}$), I_{FGM}	2A
Peak Forward Gate Voltage ($t = 10\mu\text{s}$), V_{FGM}	15V
Peak Reverse Gate Voltage, V_{RGM}	5V

Electrical Characteristics: ($T_J = +25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Gate Trigger Current	I_{GT}	$V_D = 12\text{V}$, $R_L = 33\Omega$, $t_p \geq 20\mu\text{s}$	—	—	80	mA
Gate Trigger Voltage	V_{GT}		—	—	1.5	V
Gate Non-Trigger Voltage	V_{GD}	$T_J = +125^\circ\text{C}$, $V_D = 800\text{V}$, $R_L = 3.3\text{k}\Omega$	0.2	—	—	V
Holding Current	I_H	$I_T = 0.5\text{A}$, Gate Open	—	20	150	mA
Peak On-State Voltage	V_{TM}	$I_{TM} = 100\text{A}$, $t_p = 10\text{ms}$	—	—	1.9	V
Forward Leakage Current	I_{DRM}	$V_{DRM} = 800\text{V}$	—	—	0.02	mA
			—	—	6.0	mA
Reverse Leakage Current	I_{RRM}	$V_{DRM} = 800\text{V}$	—	—	0.02	mA
			—	—	6.0	mA
Total Turn-On Time	t_{gt}	$I_T = 80\text{A}$, $V_D = 800\text{V}$, $I_G = 200\text{mA}$, $dI_G/dt = 0.2\text{A}/\mu\text{s}$	—	2	—	μs
Turn-Off Time	t_q	$T_J = +125^\circ\text{C}$, $I_T = 80\text{A}$, $V_R = 75\text{V}$, $V_D = 536\text{V}$, $dI_R/dt = 30\text{A}/\mu\text{s}$, $dv/dt = 20\text{V}/\mu\text{s}$, Gate Open	—	100	—	μs
Critical Rate of Rise of Off-State Voltage	dv/dt	$T_J = +125^\circ\text{C}$, $V_{DRM} = 536\text{V}$, Gate Open, Linear Slope Up	500	—	—	$\text{V}/\mu\text{s}$



NOTE: Dotted line indicates that case may have square corners.